Search Notes

Application/Control No.		Applicant(s)/Patent under Reexamination		
10/829,172		TERAO, KE	NJI	
Examiner		Art Unit		
Dac V. Ha		2611		

SEARCHED				
Class	Subclass	Date	Examiner	
375	267, 345	6/18/2007	DH	
	347			
1				
455	67.11			
	133-136			
	232.1			
	233.1			
	234.1			
	240.1			
	245.1			
	277.1			
	277.2			
- 1				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u></u>			

SE (INCLUDIN)	ARCH NOTES SEARCH STRAT	EGY)
	DAT	1
BRS	6/18/2	007 DH